Se	arch No	tes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/087,297	KATZ ET AL.	
Examiner	Art Unit	
Thai Phan	2128	

	SEAR	CHED	
Class	Subclass	Date	Examiner
716	10	6/9/2006	T.P
716	18	6/9/2006	T.P.
714	733	6/9/2006	TP

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

(INCLUDING SEAR	CH STRATEGY	<u>()</u>
	DATE	EXMR